

## 1200V Trench and Fieldstop IGBT

| PRODUCT SUMMARY   |                |                |
|-------------------|----------------|----------------|
| $V_{CE}$ (V)      | 1200           |                |
| $I_C$ (A)         | 100 (TC=25 °C) | 50 (TC=100 °C) |
| $V_{CE(sat)}$ (V) | 1.7            |                |
| $I_{CM}$ (A)      | 150            |                |

### FEATURES

- Very Low  $V_{CEsat}$
- Low turn-off losses
- High speed switching
- Maximum junction temperature 175°C
- Ultra low gate charge ( $Q_g$ )
- Avalanche energy rated (UIS)



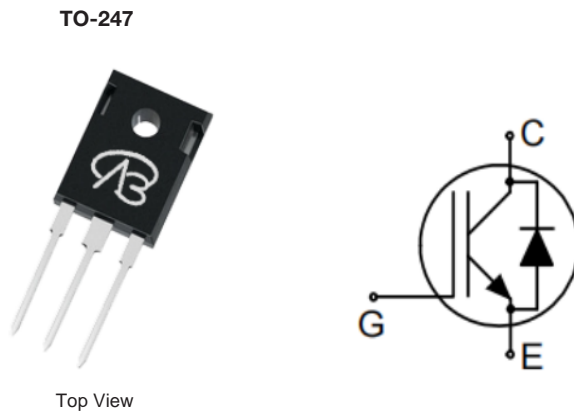
**RoHS**  
COMPLIANT  
HALOGEN  
**FREE**

### APPLICATIONS

- Telecommunications
  - Server and telecom power supplies
- Lighting
  - High-intensity discharge (HID)
  - Fluorescent ballast lighting
- Consumer and computing
  - ATX power supplies
- Industrial
  - Welding
  - Battery chargers
- Renewable energy
  - Solar (PV inverters)
- Switch mode power supplies (SMPS)

### Package pin definition

- Pin1 G - Gate
- Pin2 C & backside - Collector
- Pin3 E - Emitter



| ABSOLUTE MAXIMUM RATINGS ( $T_C = 25\text{ °C}$ , unless otherwise noted) |                            |                |                       |         |
|---|----------------------------|----------------|-----------------------|---------|
| PARAMETER   |                            | SYMBOL         | LIMIT                 | UNIT    |
| Collector-Emitter Voltage   |                            | $V_{CE}$       | 1200                  | V       |
| Gate-Emitter Voltage  |                            | $V_{GE}$       | $\pm 30$              |         |
| Continuous Collector Current ( $T_J = 150\text{ °C}$ )                    | $V_{GE}$ at 15 V           | $I_C$          | $T_C = 25\text{ °C}$  | 100     |
|   |                            |                | $T_C = 100\text{ °C}$ | 50      |
| Pulsed Collector Current <sup>a</sup>                                     |                            | $I_{CM}$       | 150                   | A       |
| Diode Forward Current <sup>b</sup>  |                            | $I_F$          | 50                    | A       |
| Maximum Power Dissipation   |                            | $P_D$          | $T_C = 25\text{ °C}$  | 800     |
|   |                            |                | $T_C = 100\text{ °C}$ | 400     |
| Operating Junction and Storage Temperature Range                          |                            | $T_J, T_{stg}$ | -55 to +175           | °C      |
| Short Circuit Withstand Time $T_C=150$                                    | $V_{GE}= 15V, V_{CE} 400V$ | tsc            | 3                     | $\mu s$ |
| Short Circuit Withstand Time $T_C=100$                                    | $V_{GE}= 15V, V_{CE} 330V$ |                | 5                     |         |
| Soldering Recommendations (Peak Temperature) <sup>c</sup>                 | for 10 s                   |                | 260                   | °C      |

#### Notes

- Repetitive rating; pulse width limited by maximum junction temperature.
- Current limited by maximum junction temperature.
- 1.6 mm from case.

| THERMAL RESISTANCE RATINGS  |            |      |      |      |
|-----------------------------|------------|------|------|------|
| PARAMETER                   | SYMBOL     | TYP. | MAX. | UNIT |
| Maximum Junction-to-Ambient | $R_{thJA}$ | -    | 40   | °C/W |
| Maximum Junction-to-Case    | $R_{thJC}$ | -    | 0.17 |      |

| SPECIFICATIONS ( $T_J = 25\text{ }^\circ\text{C}$ , unless otherwise noted) |               |  |  |              |        |        |               |
|---|---------------|--|--|--------------|--------|--------|---------------|
| PARAMETER   | SYMBOL        | TEST CONDITIONS  |  | MIN.         | TYP.   | MAX.   | UNIT          |
| <b>Static</b>   |               |  |  |              |        |        |               |
| Collector-Emitter Breakdown Voltage   | $BV_{CE}$     | $V_{GE} = 0\text{ V}, I_C = 250\text{ }\mu\text{A}$<br>$V_{GE} = 0\text{ V}, I_C = 1\text{ mA}$                |  | 1200<br>1200 | -<br>- | -<br>- | V             |
| Gate-Source Threshold Voltage (N)   | $V_{GE(th)}$  | $V_{CE} = V_{GE}, I_D = 250\text{ }\mu\text{A}$  |  | 4            | 5      | 6      | V             |
| Zero Gate Voltage Collector Current   | $I_{CES}$     | $V_{CE} = 1200\text{ V}, V_{GE} = 0\text{ V}, T_J = 25\text{ }^\circ\text{C}$                                  |  | -            | 1      | 20     | $\mu\text{A}$ |
|   |               | $V_{CE} = 1200\text{ V}, V_{GE} = 0\text{ V}, T_J = 150\text{ }^\circ\text{C}$                                 |  | -            | 1000   | -      | $\mu\text{A}$ |
| Gate-Emitter Leakage Current  | $I_{GES}$     | $V_{CE} = 0\text{ V}, V_{GS} = \pm 2.0\text{ V}$   |  | -            | -      | 100    | nA            |
| Collector-Emitter Saturation Voltage  | $V_{CE(sat)}$ | $V_{GE} = 15\text{ V}$   | $I_C = 50\text{ A}$                        | -            | 1.8    | 2.1    | V             |
| Forward Transconductance  | $g_{fs}$      | $V_{CE} = 20\text{ V}, I_C = 50\text{ A}$  |  | -            | 40     | -      | S             |
| <b>Dynamic</b>  |               |  |  |              |        |        |               |
| Input Capacitance   | $C_{ies}$     | $V_{GE} = 0\text{ V}, V_{CE} = 25\text{ V},$<br>$f = 500\text{ KHz}$   |  | -            | 5500   | -      | pF            |
| Output Capacitance  | $C_{oes}$     |  |  | -            | 210    | -      |               |
| Reverse Transfer Capacitance  | $C_{res}$     |  |  | -            | 58     | -      |               |
| Turn-on Energy  | $E_{on}$      | $V_{CE} = 400\text{ V}, V_{GE} = 0/15\text{V},$<br>$I_C = 50\text{ A}, R_g = 10\Omega$                         |  | -            | 0.41   | -      | nJ            |
| Turn-off Energy   | $E_{off}$     |  |  | -            | 0.24   | -      |               |
| Total Gate Charge   | $Q_g$         | $V_{GE} = 15\text{ V}$   | $I_C = 50\text{ A}, V_{CE} = 400\text{ V}$ | -            | 130    | -      | nC            |
| Gate-Emitter Charge   | $Q_{ge}$      |  |  | -            | 14     | -      |               |
| Gate to Collector Charge  | $Q_{gc}$      |  |  | -            | 31     | -      |               |
| Turn-On Delay Time  | $t_{d(on)}$   | $V_{CE} = 400\text{ V}, V_{GE} = 0/15\text{V},$<br>$I_C = 50\text{ A}, R_g = 10\Omega$                         |  | -            | 46     | -      | ns            |
| Rise Time   | $t_r$         |  |  | -            | 41     | -      |               |
| Turn-Off Delay Time   | $t_{d(off)}$  |  |  | -            | 167    | -      |               |
| Fall Time   | $t_f$         |  |  | -            | 36     | -      |               |
| Internal emitter inductance measured 5 mm                                   | $L_E$         |  |  | -            | 13     | -      |               |
| <b>Diode Characteristics</b>  |               |  |  |              |        |        |               |
| Diode Forward Current   | $I_F$         | IGBT symbol showing the<br>integral reverse junction diode   |  | -            | -      | 50     | A             |
| Pulsed Diode Forward Current  | $I_{FM}$      |  |  | -            | -      | 150    |               |
| Diode Forward Voltage   | $V_F$         | $I_F = 50\text{ A}$  |  | -            | 1.85   | 2.0    | V             |
| Reverse Recovery Time   | $t_{rr}$      | $T_J = 25\text{ }^\circ\text{C}, I_F = 50\text{ A},$<br>$di/dt = 200\text{ A}/\mu\text{s}, V_R = 400\text{ V}$ |  | -            | 63     | -      | ns            |
| Reverse Recovery Charge   | $Q_{rr}$      |  |  | -            | 0.3    | -      | $\mu\text{C}$ |
| Reverse Recovery Current  | $I_{RRM}$     |  |  | -            | 11     | -      | A             |

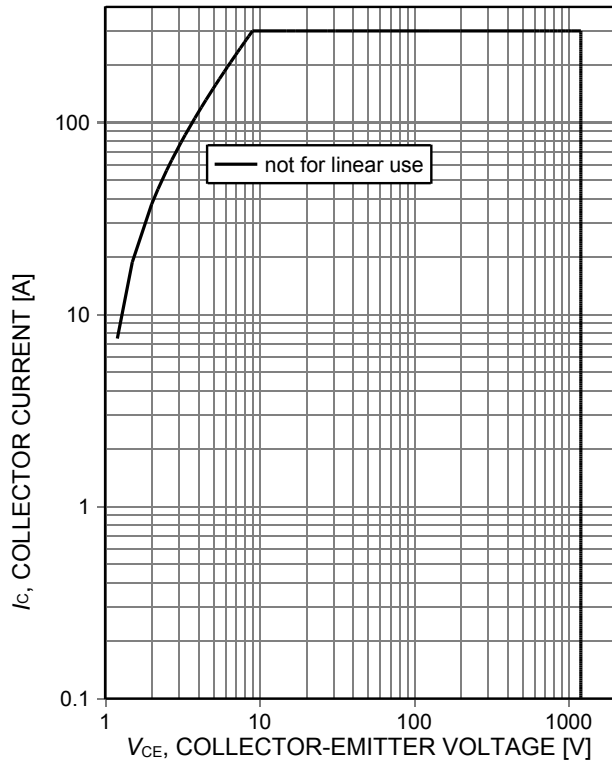


Figure 1. Forward bias safe operating area

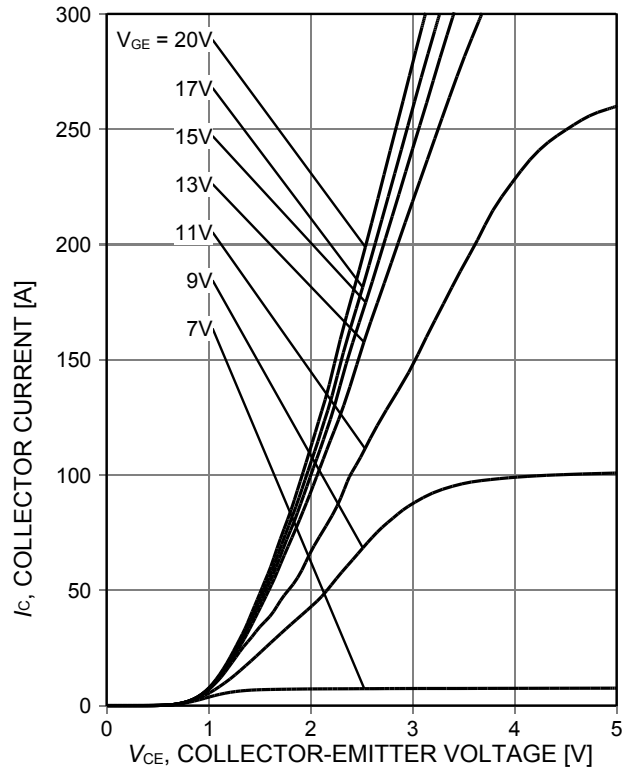


Figure 2. Typical output characteristic

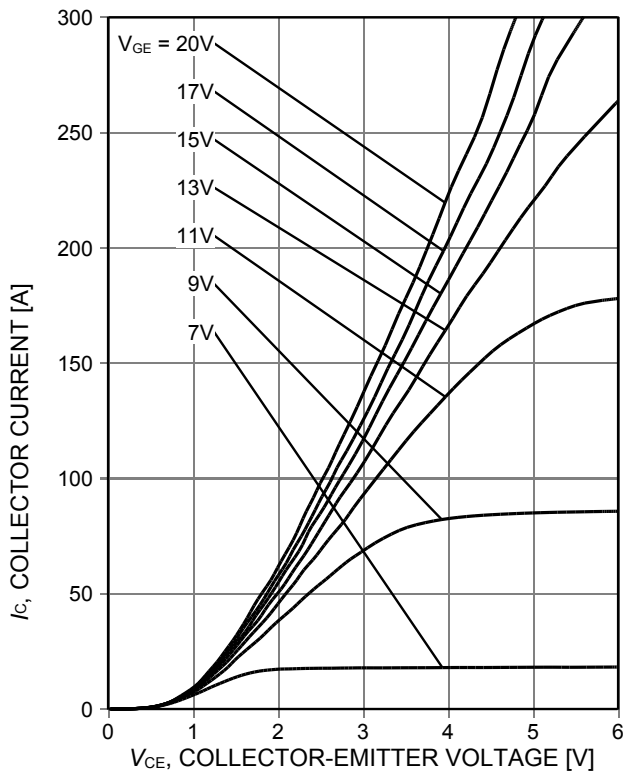


Figure 3. Typical output characteristic

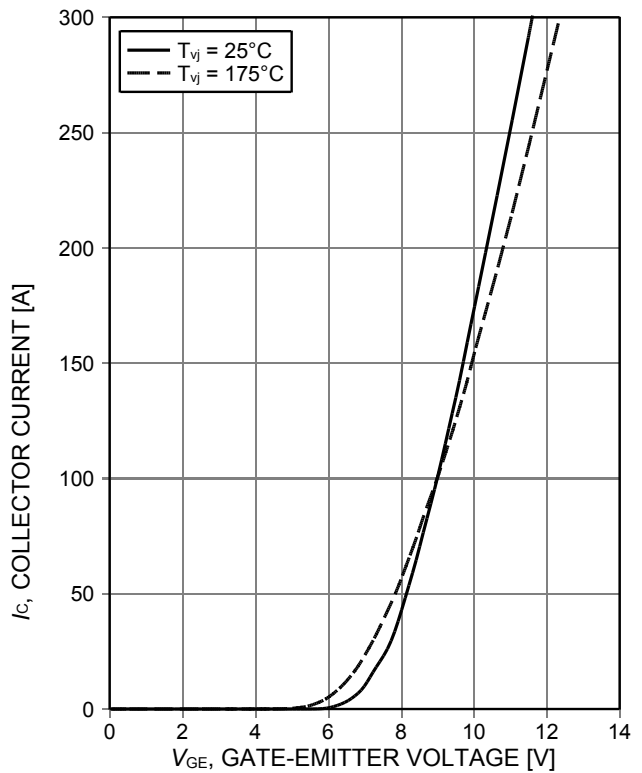


Figure 4. Typical transfer characteristic

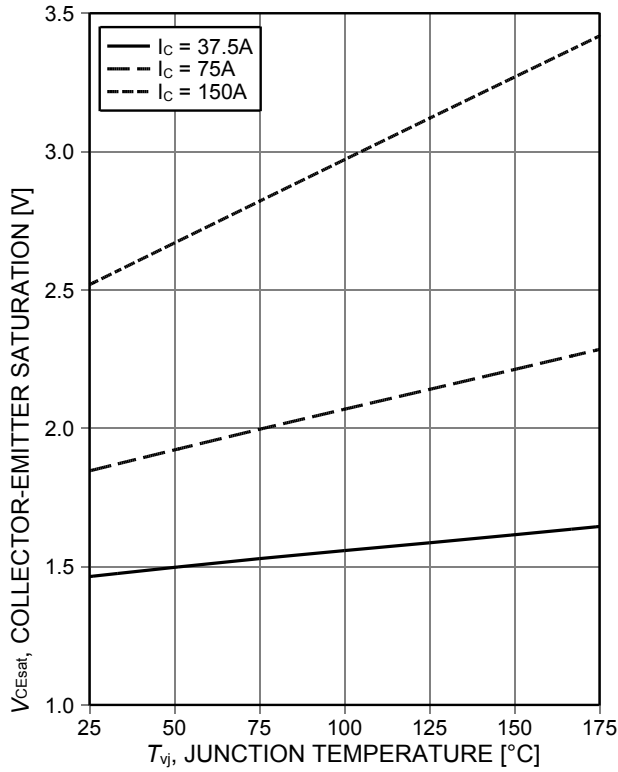


Figure 5. Typical collector-emitter saturation voltage as a function of junction temperature

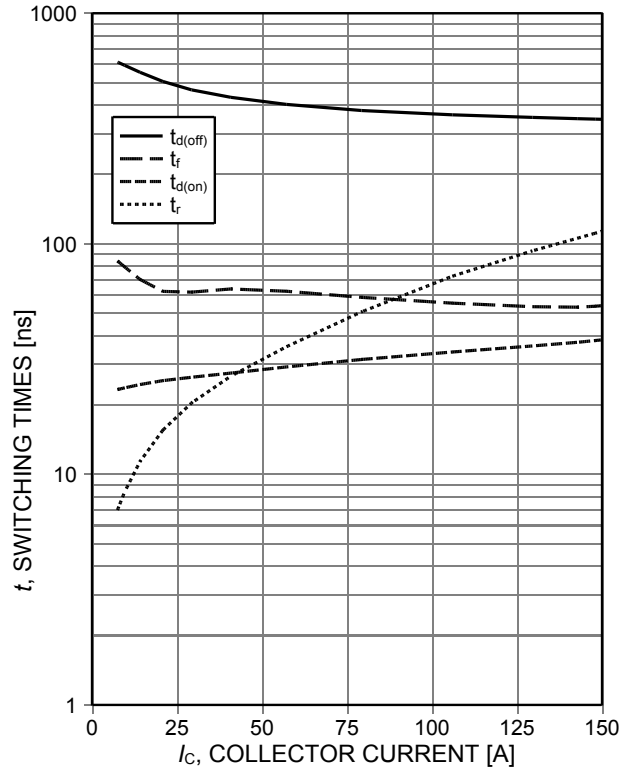


Figure 6. Typical switching times as a function of collector current

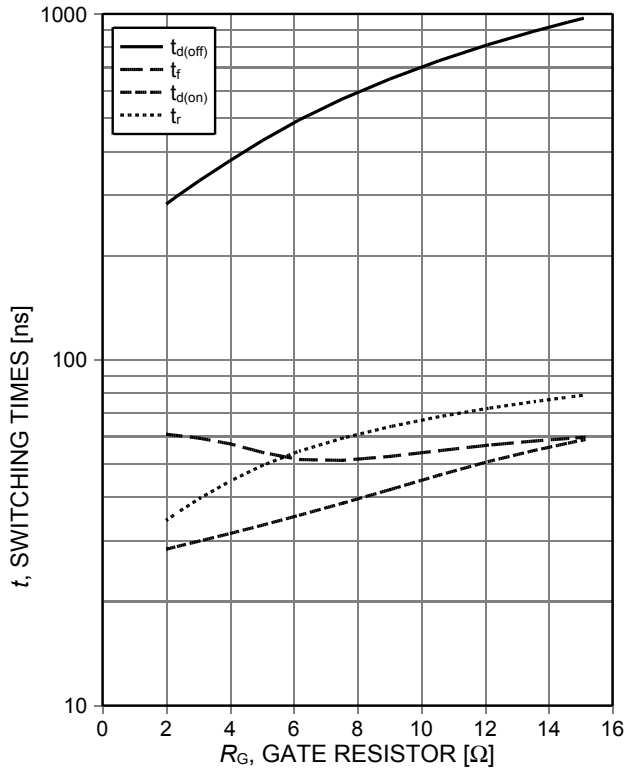


Figure 7. Typical switching times as a function of gate resistor

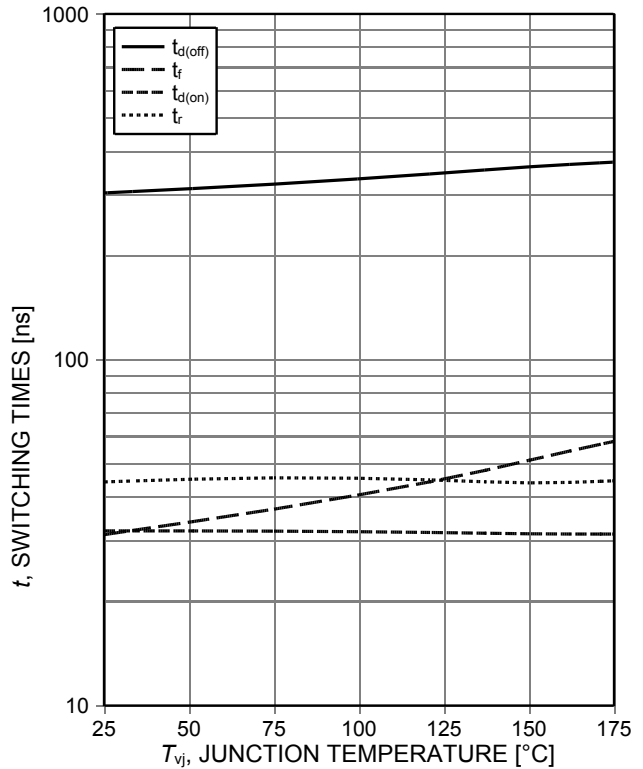


Figure 8. Typical switching times as a function of junction temperature

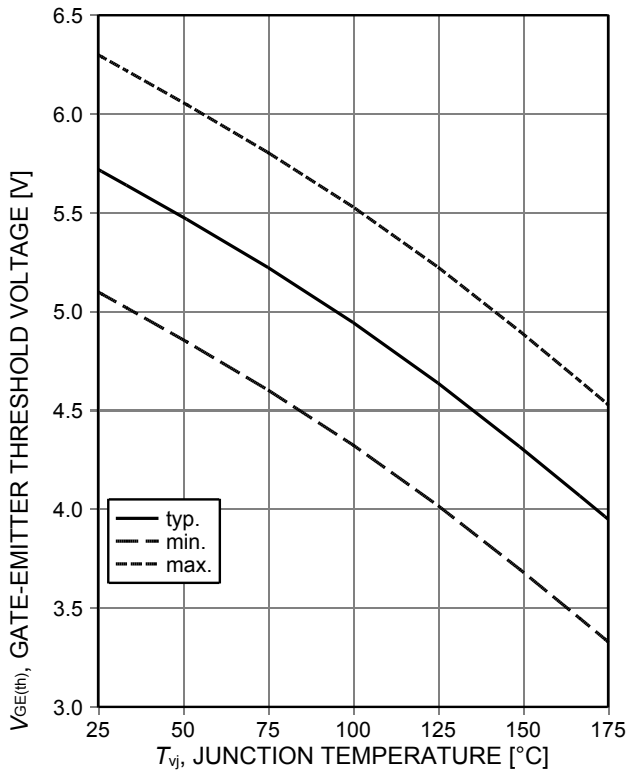


Figure 9. Gate-emitter threshold voltage as a function of junction temperature

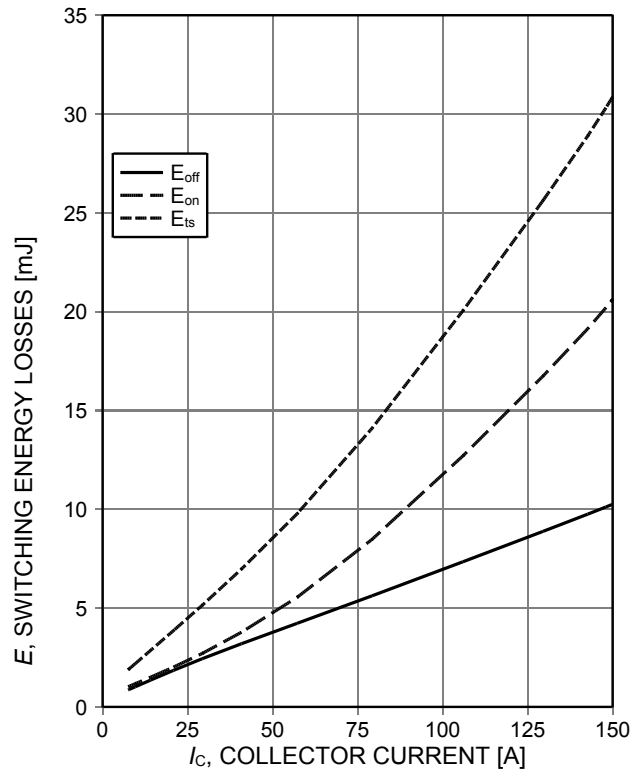


Figure 10. Typical switching energy losses as a function of collector current

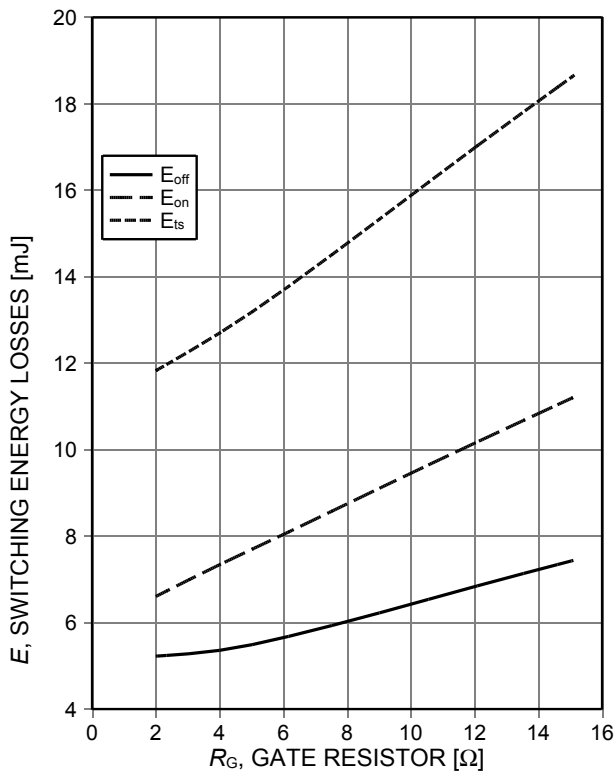


Figure 11. Typical switching energy losses as a function of gate resistor

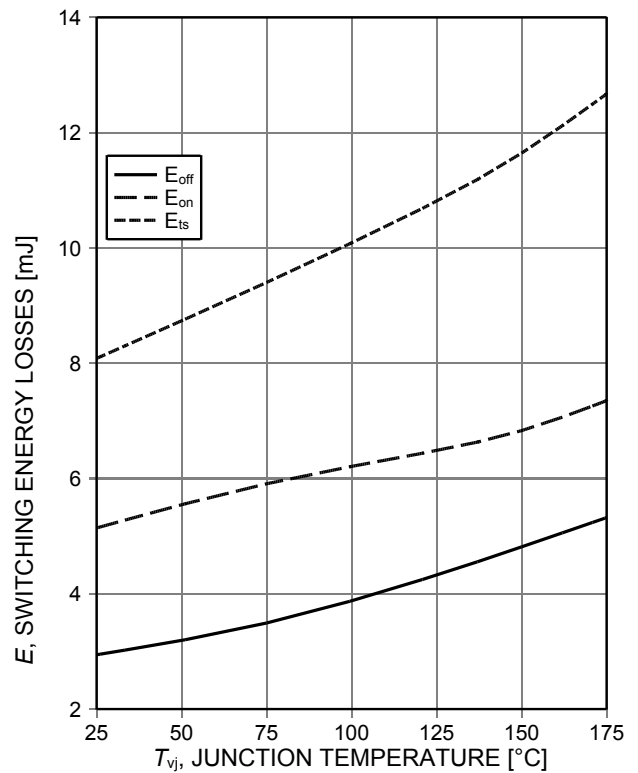


Figure 12. Typical switching energy losses as a function of junction temperature

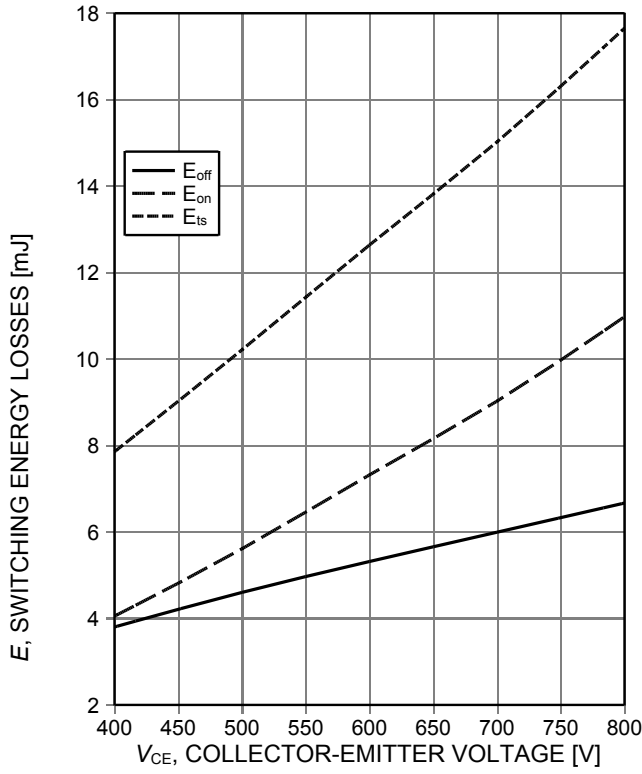


Figure 13. Typical switching energy losses as a function of collector emitter voltage

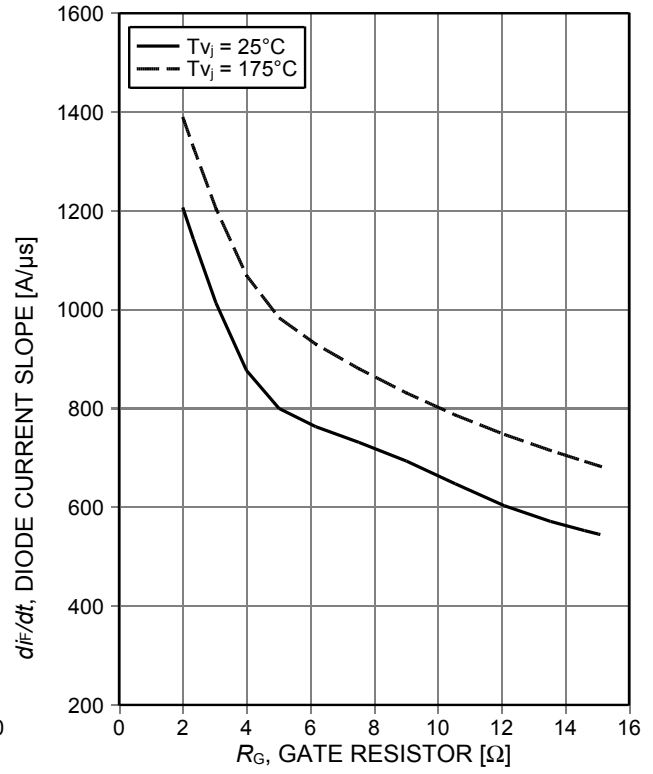


Figure 14. Typical diode current slope as a function of gate resistor

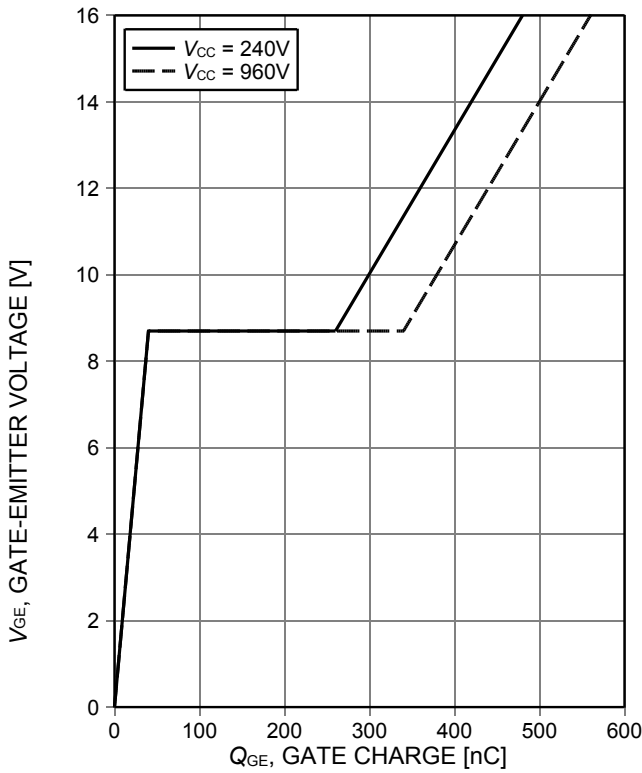


Figure 15. Typical gate charge

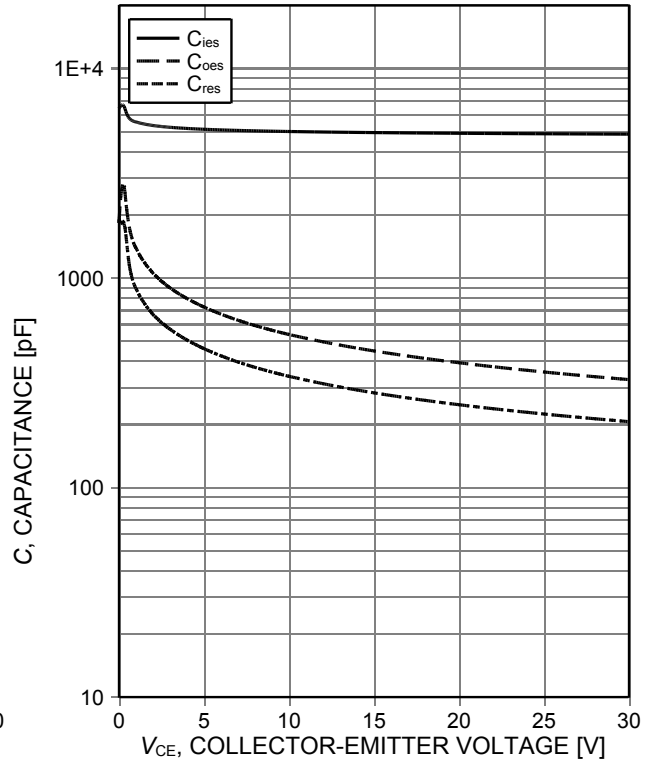


Figure 16. Typical capacitance as a function of collector-emitter voltage

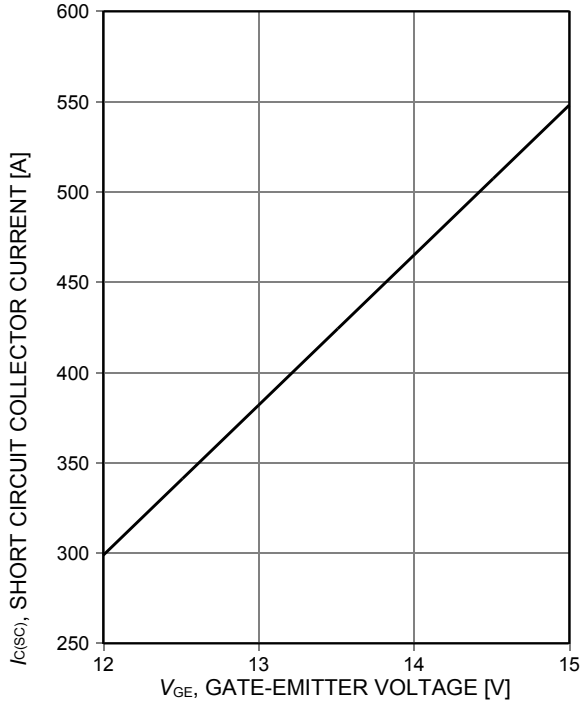


Figure 17. Typical short circuit collector current as a function of gate-emitter voltage

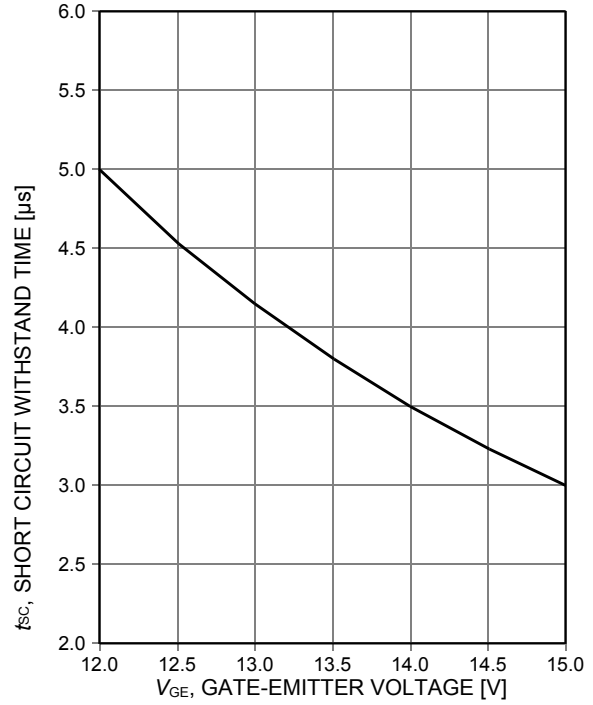


Figure 18. Short circuit withstand time as a function of gate-emitter voltage

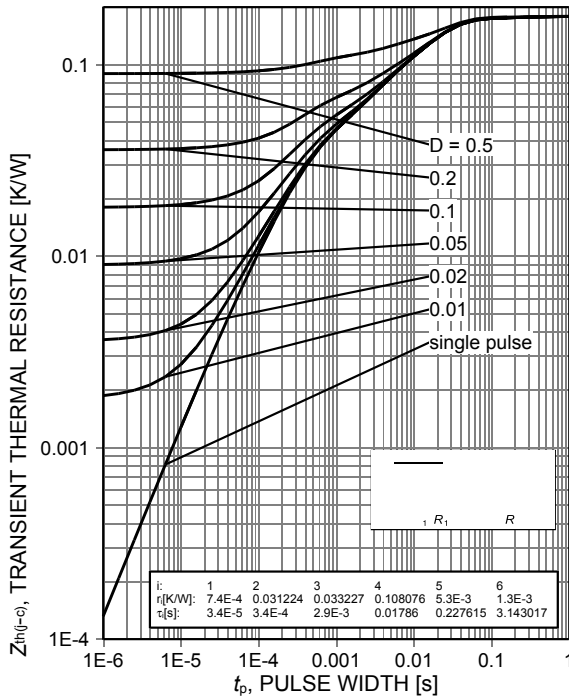


Figure 19. IGBT transient thermal resistance

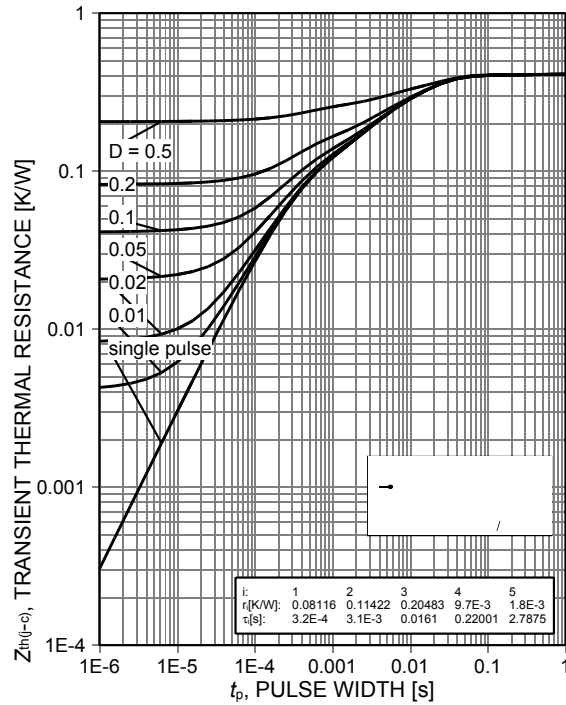


Figure 20. Diode transient thermal impedance as a function of pulse width

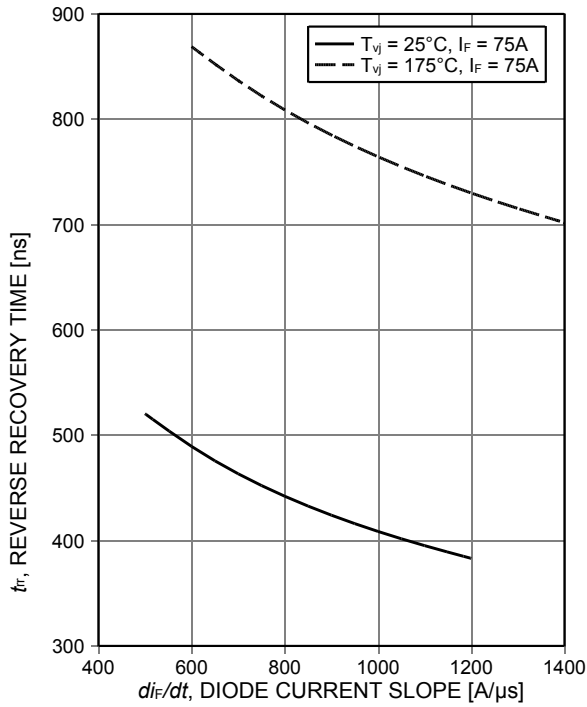


Figure 21. Typical reverse recovery time as a function of diode current slope

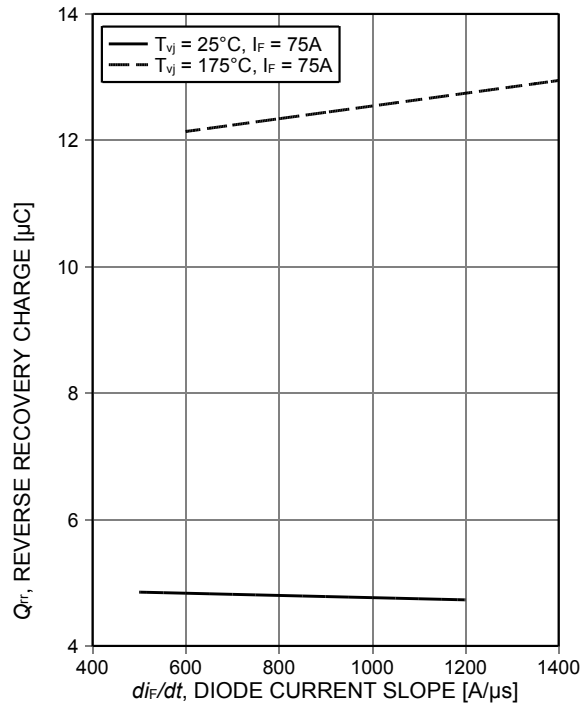


Figure 22. Typical reverse recovery charge as a function of diode current slope

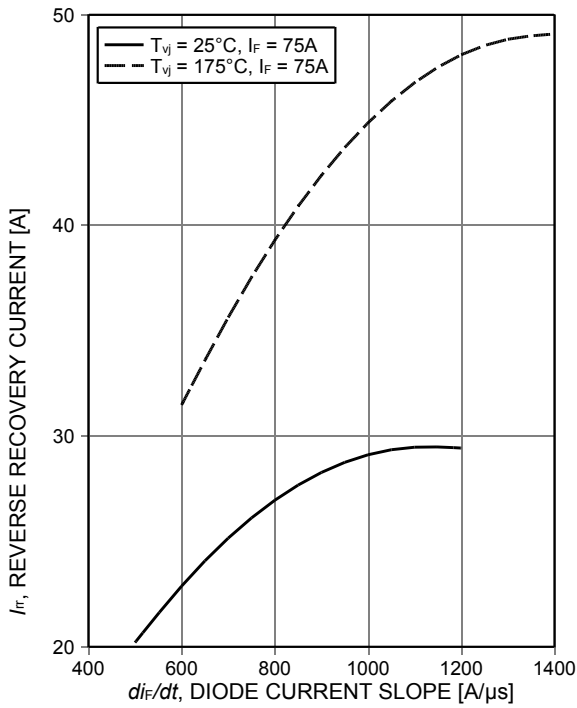


Figure 23. Typical reverse recovery current as a function of diode current slope

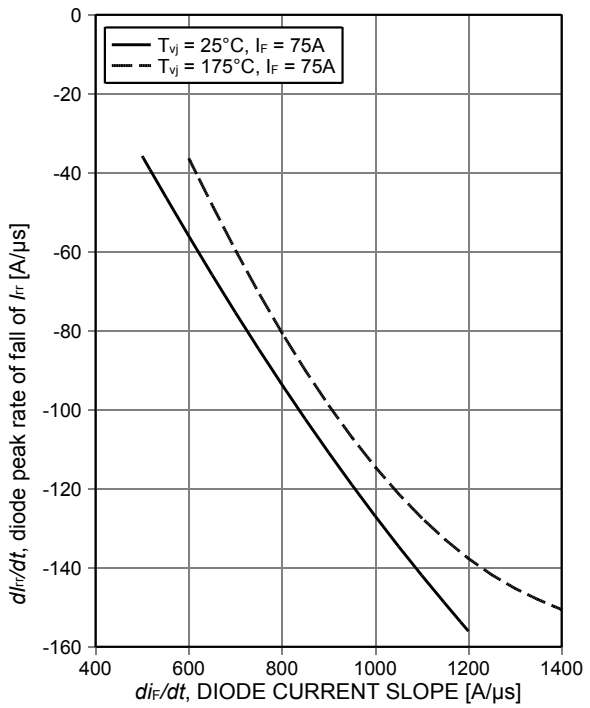


Figure 24. Typical diode peak rate of fall of reverse recovery current as a function of diode current slope

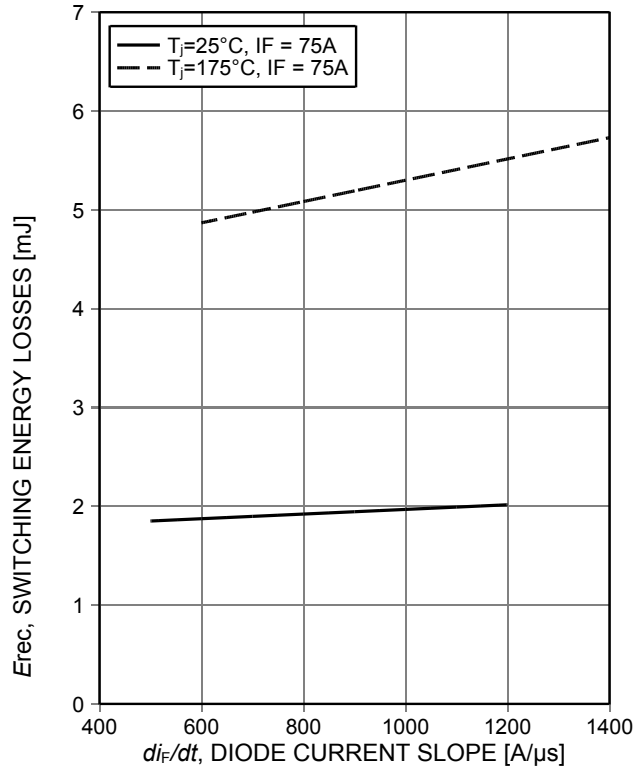


Figure 25. Typical reverse energy losses as a function of diode current slope

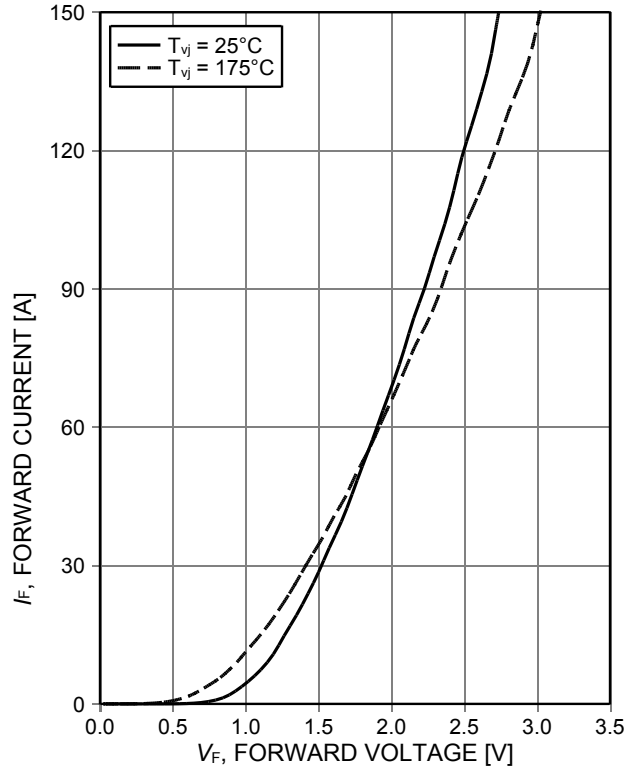


Figure 26. Typical diode forward current as a function of forward voltage

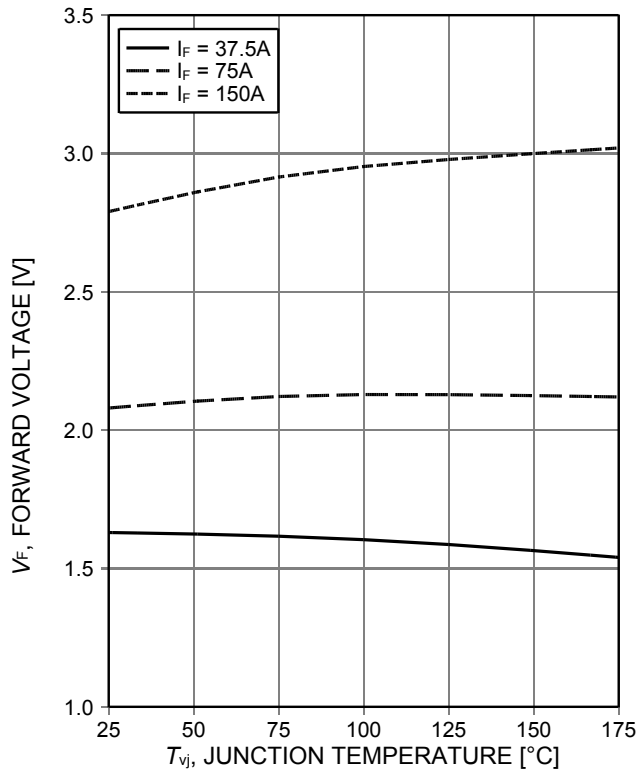
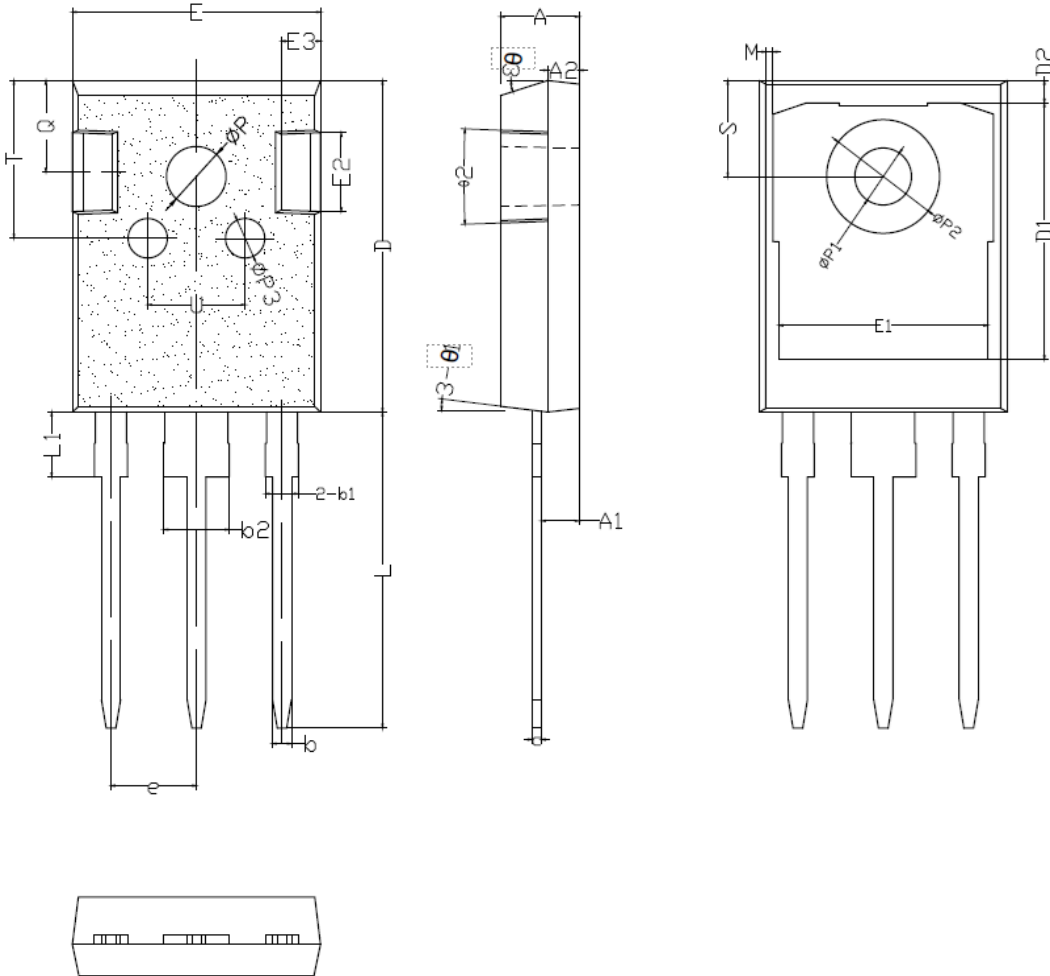


Figure 27. Typical diode forward voltage as a function of junction temperature

TO-247 PACKAGE OUTLINE DIMENSIONS



| SYMBOL | mm    |       |       |
|--------|-------|-------|-------|
|        | MIN   | NOM   | MAX   |
| *A     | 4.90  | 5.00  | 5.10  |
| *A1    | 2.31  | 2.41  | 2.51  |
| A2     | 1.90  | 2.00  | 2.10  |
| *b     | 1.15  | 1.20  | 1.25  |
| *b1    | 1.95  | 2.10  | 2.25  |
| *b2    | 2.95  | 3.10  | 3.25  |
| *c     | 0.55  | 0.60  | 0.65  |
| *D     | 20.90 | 21.00 | 21.10 |
| D1     | 16.35 | 16.55 | 16.75 |
| D2     | 1.05  | 1.20  | 1.35  |

|      |       |       |       |
|------|-------|-------|-------|
| *E   | 15.70 | 15.80 | 15.90 |
| E1   | 13.10 | 13.25 | 13.40 |
| E2   | 4.85  | 4.95  | 5.10  |
| E3   | 2.40  | 2.50  | 2.60  |
| *e   | 5.40  | 5.44  | 5.48  |
| *L   | 19.80 | 19.98 | 20.15 |
| *L1  | -     | -     | 4.30  |
| *ΦP  | 3.40  | 3.50  | 3.60  |
| *ΦP1 | 6.90  | 7.10  | 7.30  |
| ΦP2  | 2.40  | 2.50  | 2.60  |
| ΦP3  | 2.40  | 2.50  | 2.60  |
| Q    | 5.60  | 5.80  | 6.00  |
| *S   | 6.05  | 6.15  | 6.25  |
| T    | 9.80  | 10.00 | 10.20 |
| U    | 6.00  | 6.20  | 6.40  |
| θ1   | 5°    | 7°    | 9°    |
| θ2   | 1°    | 3°    | 5°    |
| θ3   | 13°   | 15°   | 17°   |
|      |       |       |       |

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